

MOSFETs Silicon P-Channel MOS (U-MOSVI)

# SSM3J66MFV

#### 1. Applications

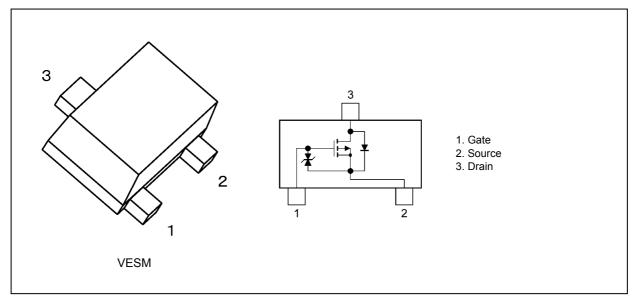
· Load Switches

#### 2. Features

- (1) AEC-Q101 qualified (Note 1)
- (2) 1.2-V drive
- (3) Low drain-source on-resistance
  - $: R_{DS(ON)} = 390 \text{ m}\Omega \text{ (max) } (@V_{GS} = -4.5 \text{ V})$ 
    - $R_{\rm DS(ON)} = 480 \ {\rm m}\Omega \ ({\rm max}) \ (@V_{\rm GS} = -2.5 \ {\rm V})$
    - $R_{\rm DS(ON)} = 660 \ {\rm m}\Omega \ ({\rm max}) \ (@V_{\rm GS} = -1.8 \ {\rm V})$
    - $R_{\rm DS(ON)}$  = 900 m $\Omega$  (max) (@ $V_{\rm GS}$  = -1.5 V)
    - $R_{DS(ON)} = 4000 \text{ m}\Omega \text{ (max) (@V_{GS} = -1.2 V)}$

Note 1: For detail information, please contact to our sales.

### 3. Packaging and Pin Configuration





### 4. Absolute Maximum Ratings (Note) (Unless otherwise specified, Ta = 25 °C)

	Characteristics			Symbol	Rating	Unit
Drain-source voltage				$V_{DSS}$	-20	V
Gate-source voltage				$V_{GSS}$	-8/+6	
Drain current (DC)			(Note 1)	I <sub>D</sub>	-0.8	Α
Drain current (pulsed)			(Note 1), (Note 2)	I <sub>DP</sub>	-1.6	
Power dissipation			(Note 3)	$P_{D}$	150	mW
Power dissipation			(Note 4)	P <sub>D</sub>	500	
Power dissipation		(t < 5 s)	(Note 4)	$P_D$	800	
Channel temperature				T <sub>ch</sub>	150	°C
Storage temperature				T <sub>stg</sub>	-55 to 150	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

- Note 1: Ensure that the channel temperature does not exceed 150 °C.
- Note 2: Pulse width (PW)  $\leq$  1 ms, duty < 1 %
- Note 3: Device mounted on an FR4 board.(25.4 mm × 25.4 mm × 1.6 mm, Cu pad: 0.585 mm<sup>2</sup>)
- Note 4: Device mounted on an FR4 board.(25.4 mm × 25.4 mm × 1.6 mm, Cu pad: 645 mm<sup>2</sup>)

Note: The MOSFETs in this device are sensitive to electrostatic discharge. When handling this device, the worktables, operators, soldering irons and other objects should be protected against anti-static discharge.

Note: The channel-to-ambient thermal resistance, R<sub>th(ch-a)</sub>, and the drain power dissipation, P<sub>D</sub>, vary according to the board material, board area, board thickness and pad area. When using this device, be sure to take heat dissipation fully into account.



#### 5. Electrical Characteristics

### 5.1. Static Characteristics (Unless otherwise specified, Ta = 25 °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = -8/+6 V	_	_	±1	μА
Drain cut-off current		I <sub>DSS</sub>	V <sub>DS</sub> = -20 V, V <sub>GS</sub> = 0 V	_	_	-1	
Drain-source breakdown voltage		V <sub>(BR)DSS</sub>	I <sub>D</sub> = -1 mA, V <sub>GS</sub> = 0 V	-20	_	_	V
Drain-source breakdown voltage	(Note 1)	V <sub>(BR)DSX</sub>	I <sub>D</sub> = -1 mA, V <sub>GS</sub> = 5 V	-15	_	_	
Gate threshold voltage	(Note 2)	$V_{th}$	$V_{DS} = -3 \text{ V}, I_{D} = -1 \text{ mA}$	-0.3	_	-1.0	
Drain-source on-resistance	(Note 3)	R <sub>DS(ON)</sub>	I <sub>D</sub> = -10 mA, V <sub>GS</sub> = -1.2 V	_	770	4000	mΩ
			I <sub>D</sub> = -100 mA, V <sub>GS</sub> = -1.5 V	_	560	900	
			I <sub>D</sub> = -200 mA, V <sub>GS</sub> = -1.8 V	_	470	660	
			I <sub>D</sub> = -500 mA, V <sub>GS</sub> = -2.5 V	_	380	480	
			I <sub>D</sub> = -800 mA, V <sub>GS</sub> = -4.5 V	_	310	390	
Forward transfer admittance	(Note 3)	Y <sub>fs</sub>	$V_{DS} = -3 \text{ V}, I_{D} = -100 \text{ mA}$	0.5	1.0	_	S

- Note 1: If a reverse bias is applied between gate and source, this device enters  $V_{(BR)DSX}$  mode. Note that the drain-source breakdown voltage is lowered in this mode.
- Note 2: Let  $V_{th}$  be the voltage applied between gate and source that causes the drain current ( $I_D$ ) to below (-1 mA for this device). Then, for normal switching operation,  $V_{GS(ON)}$  must be higher than  $V_{th}$ , and  $V_{GS(OFF)}$  must be lower than  $V_{th}$ . This relationship can be expressed as:  $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$ .

  Take this into consideration when using the device.

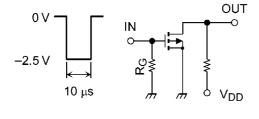
Note 3: Pulse measurement.

### 5.2. Dynamic Characteristics (Unless otherwise specified, Ta = 25 °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Input capacitance		C <sub>iss</sub>	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz	_	100		pF
Reverse transfer capacitance		C <sub>rss</sub>		_	10		
Output capacitance		C <sub>oss</sub>		_	16	_	
Switching time (turn-on time)	(Note 1)	· · · ·	$V_{DD}$ = -10 V, $I_D$ = -200 mA,	_	8	_	ns
Switching time (turn-off time)	(Note 1)	t <sub>off</sub>	$V_{GS}$ = 0 to -2.5 V, $R_{G}$ = 50 $\Omega$	_	26	_	

Note 1: Duty  $\leq$  1 %, input  $t_r$ ,  $t_f$  < 5 ns, Common source, See Chapter 5.3

#### 5.3. Switching Time Test Circuit



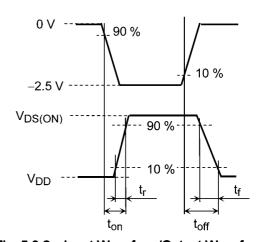


Fig. 5.3.1 Test Circuit of Switching Time

Fig. 5.3.2 Input Waveform/Output Waveform



### 5.4. Gate Charge Characteristics (Unless otherwise specified, Ta = 25 °C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Total gate charge (gate-source plus gate-drain)	$Q_g$	$V_{DD} = -10 \text{ V}, I_D = -800 \text{ mA},$	_	1.6	_	nC
Gate-source charge 1	Q <sub>gs1</sub>	$V_{GS} = -4.5 \text{ V}$	_	0.2	_	
Gate-drain charge	$Q_{gd}$		_	0.4		

### 5.5. Source-Drain Characteristics (Unless otherwise specified, T<sub>a</sub> = 25 °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Diode forward voltage	(Note 1)	$V_{DSF}$	$I_D$ = 800 mA, $V_{GS}$ = 0 V	_	0.9	1.2	V

Note 1: Pulse measurement.

### 6. Marking

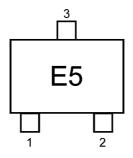


Fig. 6.1 Marking



#### 7. Characteristics Curves (Note)

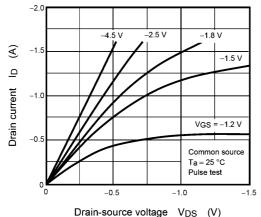


Fig. 7.1 I<sub>D</sub> - V<sub>DS</sub>

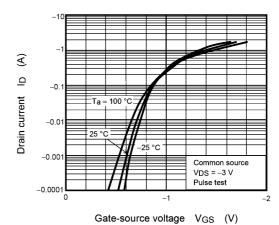


Fig. 7.2 I<sub>D</sub> - V<sub>GS</sub>

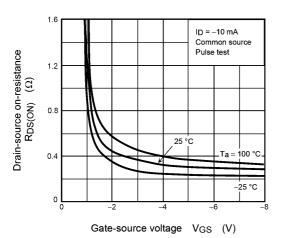


Fig. 7.3 R<sub>DS(ON)</sub> - V<sub>GS</sub>

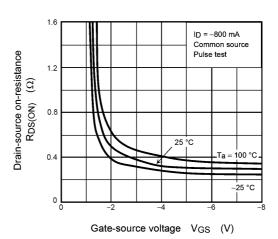


Fig. 7.4 R<sub>DS(ON)</sub> - V<sub>GS</sub>

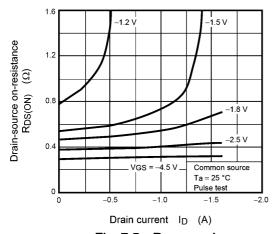


Fig. 7.5 R<sub>DS(ON)</sub> - I<sub>D</sub>

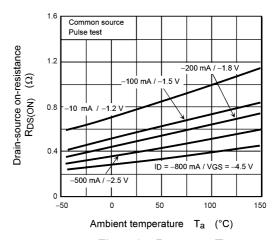


Fig. 7.6 R<sub>DS(ON)</sub> - T<sub>a</sub>



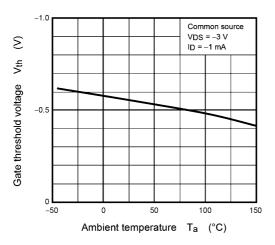
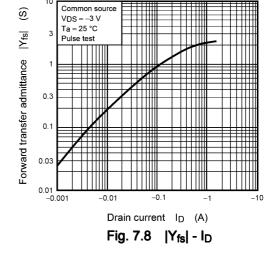


Fig. 7.7 V<sub>th</sub> - T<sub>a</sub>



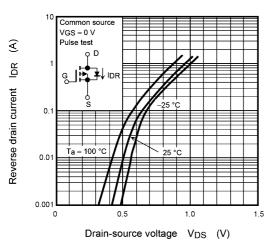


Fig. 7.9 IDR - VDS

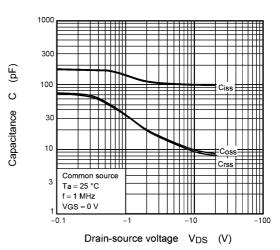


Fig. 7.10 C - V<sub>DS</sub>

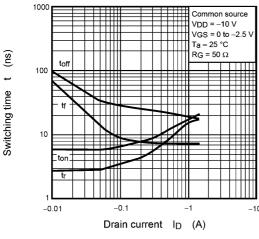


Fig. 7.11 t - ID

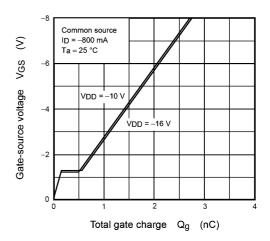
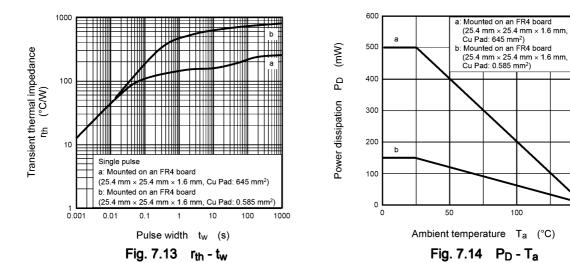


Fig. 7.12 Dynamic Input Characteristics

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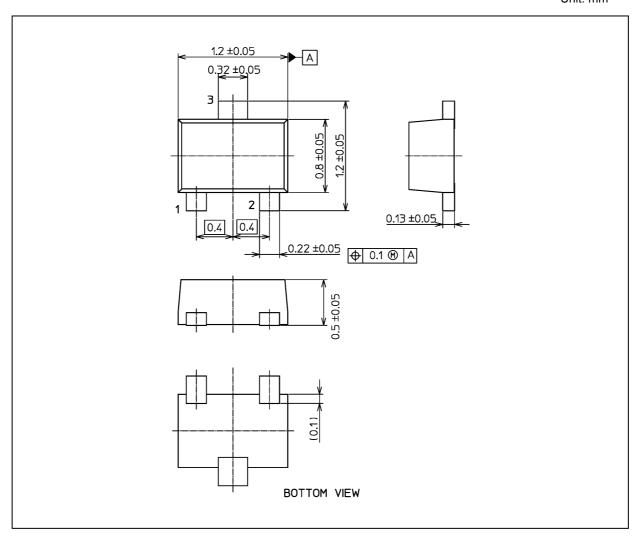


Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



### **Package Dimensions**

Unit: mm



Weight: 1.5 mg (typ.)

Package Name(s)
TOSHIBA: 1-1Q1S
Nickname: VESM



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